



# TEST REPORT

Product Name: RF card door lock  
Trademark: ALOCK Digital Locks Systems  
117AC  
Model Number: 117NF, 117F, 116NF, 117P, 89P, 89P, 116P, 116C, 117CA, 89C, 52C, 01C, 15C, 116EAC, 157C, 156C, 26C, 58AC, 116REAC, 116FEAC, 159C, 8000C, 803C, 9000C  
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Sample Received Date: Mar. 28, 2018  
Sample tested Date: Apr . 07, 2018 to Apr . 13, 2018  
Issue Date: Apr . 13, 2018  
Report No.: BCTC-FY180301608E  
Test Standards: EN 55032:2015, EN 55035: 2017  
EN 61000-3-2: 2014, EN 61000-3-3: 2013  
Test Results: PASS

Compiled by:

Icey Chen

Reviewed by:

Rita Xiao

Approved by:

Carson Zhang/Manager



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(Note: N/A means not applicable)



## 1. VERSION

Report No.	Issue Date	Description	Approved
BCTC-FY180301608E	Apr . 13, 2018	Original	Valid



## 2. TEST SUMMARY

The Product has been tested according to the following specifications:

EMISSION		
Standard	Test Item	Test result
EN 55032	Conducted emissions from the AC mains power ports	N/A <sup>3</sup>
EN 55032	Asymmetric mode conducted emissions	N/A <sup>1</sup>
EN 55032	Conducted differential voltage emissions	N/A <sup>2</sup>
EN 55032	Radiated emissions	Pass
EN 61000-3-2	Harmonic current emission(H)	N/A <sup>3</sup>
EN 61000-3-3	Voltage fluctuations & flicker(F)	N/A <sup>3</sup>

IMMUNITY (EN 55035)		
Standard	Test Item	Test result
IEC 61000-4-2	Electrostatic discharge (ESD)	Pass
IEC 61000-4-3	Continuous RF electromagnetic field disturbances(RS)	Pass <sup>#</sup>
IEC 61000-4-4	Electrical fast transients/burst (EFT)	N/A <sup>3</sup>
IEC 61000-4-5	Surges	N/A <sup>3</sup>
IEC 61000-4-6	Continuous induced RF disturbances (CS)	N/A <sup>3</sup>
IEC 61000-4-6	Broadband impulse noise disturbances, repetitive	N/A <sup>4</sup>
IEC 61000-4-6	Broadband impulse noise disturbances, isolated	N/A <sup>4</sup>
IEC 61000-4-8	Power frequency magnetic field (PFMF)	N/A <sup>5</sup>
IEC 61000-4-11	Voltage dips and interruptions (DIPS)	N/A <sup>3</sup>

Remark:

"#"indicates the testing item(s) was (were) fulfilled by subcontracted lab.

1. Applicable to ports listed above and intended to connect to cables longer than 3 m.
2. The Product has no antenna port.
3. The EUT is powered by the DC only , the test item is not applicable
4. Applicable only to CPE xDSL ports.
5. The Product doesn't contain any device susceptible to magnetic fields.



### 3. MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of  $k=2$ .

Test item	Value (dB)
Conducted Emission (150kHz-30MHz)	1.82
Radiated Emission(30MHz~1GHz)	2.51
Radiated Emission(1GHz~6GHz)	2.51



## 4. PRODUCT INFORMATION AND TEST SETUP

### 4.1 Product Information

**Ratings:**

DC 6V

**The highest frequency of the internal sources of the EUT is (less than 108)MHz:**

- ☒ less than 108 MHz, the measurement shall only be made up to 1 GHz.  
☐ between 108 MHz and 500 MHz, the measurement shall only be made up to 2 GHz.  
☐ between 500 MHz and 1 GHz, the measurement shall only be made up to 5 GHz.  
☐ above 1 GHz, the measurement shall be made up to 5 times the highest frequency or 6 GHz, whichever is less.

**Model difference:**

All models are identical except for the appearance color, the test model is 117AC and the test results are applicable to other tests.

**Cable of Product**

No.	Cable Type	Quantity	Provider	Length (m)	Specification	Note
1	--	--	Applicant	---	Shielded	With a ferrite ring in mid Detachable
2	--	--	BCTC	--	Unshielded	--

### 4.2 Test Setup Configuration

See test photographs attached in EUT TEST SETUP PHOTOGRAPHS for the actual connections between Product and support equipment.

### 4.3 Support Equipment

No.	Device Type	Brand	Model	Series No.	Data Cable	Power Cord
1.	---	---	---	---	---	---

**Notes:**

1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.



#### 4.4 Test Mode

Test item	Test Mode	Test Voltage
Radiated emissions(30MHz-1GHz) Class B	Working	DC 12V
Electrostatic discharge (ESD) B <input checked="" type="checkbox"/> Air Discharge: $\pm 8\text{kV}$ <input checked="" type="checkbox"/> Contact Discharge: $\pm 4\text{kV}$ <input checked="" type="checkbox"/> HCP & VCP: $\pm 4\text{kV}$	Working	DC 12V
Continuous RF electromagnetic field disturbances(RS) A 80MHz-1000MHz,2600MHz,3500MHz, 5000MHz, 3V/m,80%	Working	DC 12V
All test mode were tested and passed, only Conducted Emissions, Radiated Emissions		

#### 4.5 Test Environment

Temperature:	26°C
Humidity:	55%
Atmospheric Pressure:	101.48 kPa





## 5. TEST FACILITY AND TEST INSTRUMENT USED

### 5.1 Test Facility

All measurement facilities used to collect the measurement data are located at BCTC Building & 1-2F, East of B Building, Pengzhou Industrial, Fuyuan 1st Road, Qiaotou Community, Fuyong Street, Bao'an District, Shenzhen, China. The site and apparatus are constructed in conformance with the requirements of ANSI C63.4 and CISPR 16-1-1 other equivalent standards.

### 5.2 Test Instrument Used

Radiated emissions Test (966 chamber)					
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.
966 chamber	ChengYu	966 Room	966	Aug. 25, 2017	Aug. 24, 2018
Receiver	R&S	ESRP	101154	Aug. 14, 2017	Aug. 13, 2018
Amplifier	Schwarzbeck	BBV9718	9718-309	Aug. 14, 2017	Aug. 13, 2018
Amplifier	Schwarzbeck	BBV9744	9744-0037	Aug. 14, 2017	Aug. 13, 2018
TRILOG Broadband Antenna	schwarzbeck	VULB 9163	VULB9163-942	Aug. 13, 2017	Aug. 12, 2018
Horn Antenna	SCHWARZBECK	BBHA9120 D	1201	Aug. 16, 2017	Aug. 15, 2018

Electrostatic discharge Test					
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.
ESD Tester	3C TEST	EDS 30V	ES0121614	Aug. 16, 2017	Aug. 15, 2018
ESD Tester	KIKISUI	KES4201A	UH002321	Aug. 15, 2017	Aug. 14, 2018



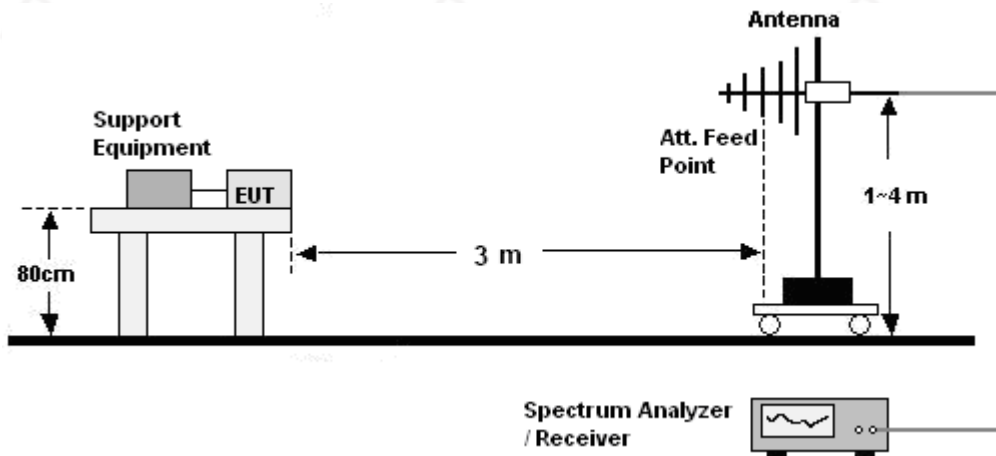


Continuous RF electromagnetic field disturbances Test (SMQ --- site )					
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.
Signal Generator	HP	8648A	3625U0057 3	Sep. 26, 2017	Sep. 26, 2018
Amplifier	A&R	500A100	17034	Sep. 26, 2017	Sep. 26, 2018
Amplifier	A&R	100W/1000M 1	17028	Sep. 26, 2017	Sep. 26, 2018
Audio Analyzer (20Hz~1GHz)	Panasonic	2023B	202301/428	Sep. 26, 2017	Sep. 26, 2018
Isotropic Field Probe	A&R	FP2000	16755	Sep. 26, 2017	Sep. 26, 2018
Antenna	EMCO	3108	9507-2534	Sep. 26, 2017	Sep. 26, 2018
Log-periodic Antenna	A&R	AT1080	16812	Sep. 26, 2017	Sep. 26, 2018

## 6. RADIATED EMISSIONS TEST

### 6.1 Block Diagram Of Test Setup

30MHz ~ 1GHz:



### 6.2 Limits

Limits for radiated disturbance of Class B MME

Frequency (MHz)	Quasi-peak limits at 3m dB( $\mu$ V/m)
30-230	40
230-1000	47

**Note:** The lower limit shall apply at the transition frequencies.

### 6.3 Test Procedure

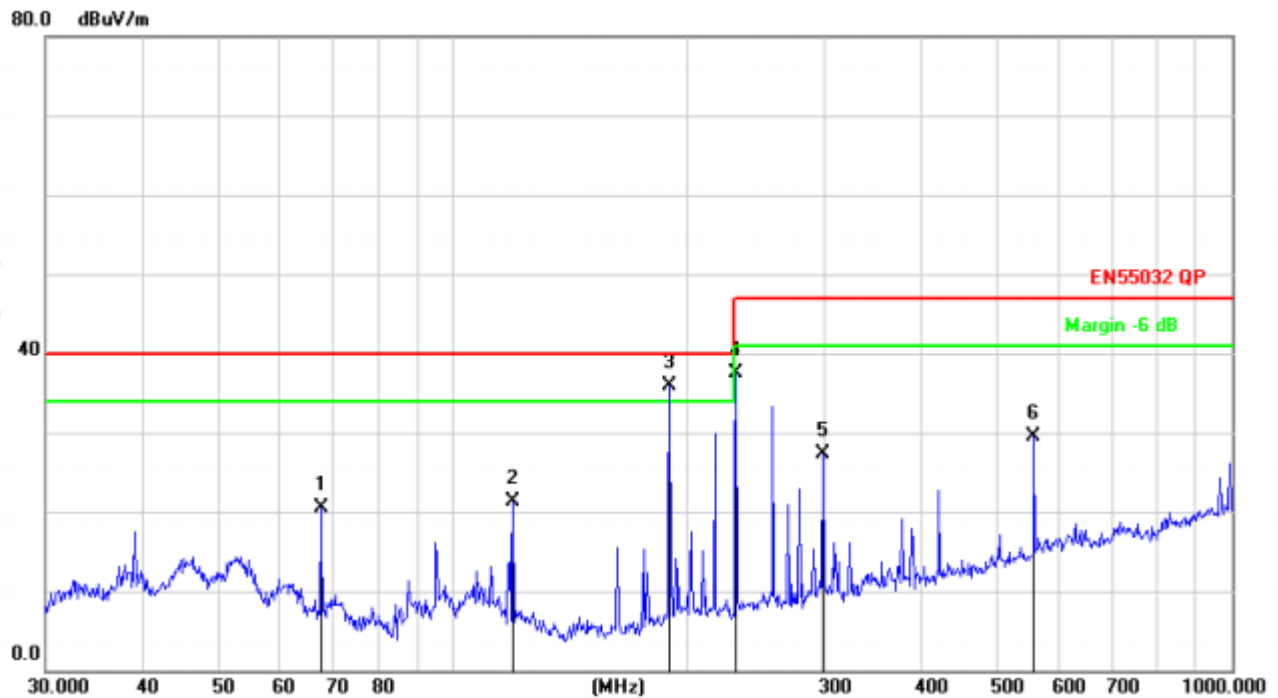
30MHz ~ 1GHz:

- The Product was placed on the nonconductive turntable 0.8m above the ground in a semi anechoic chamber.
- Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.



## 6.4 Test Results

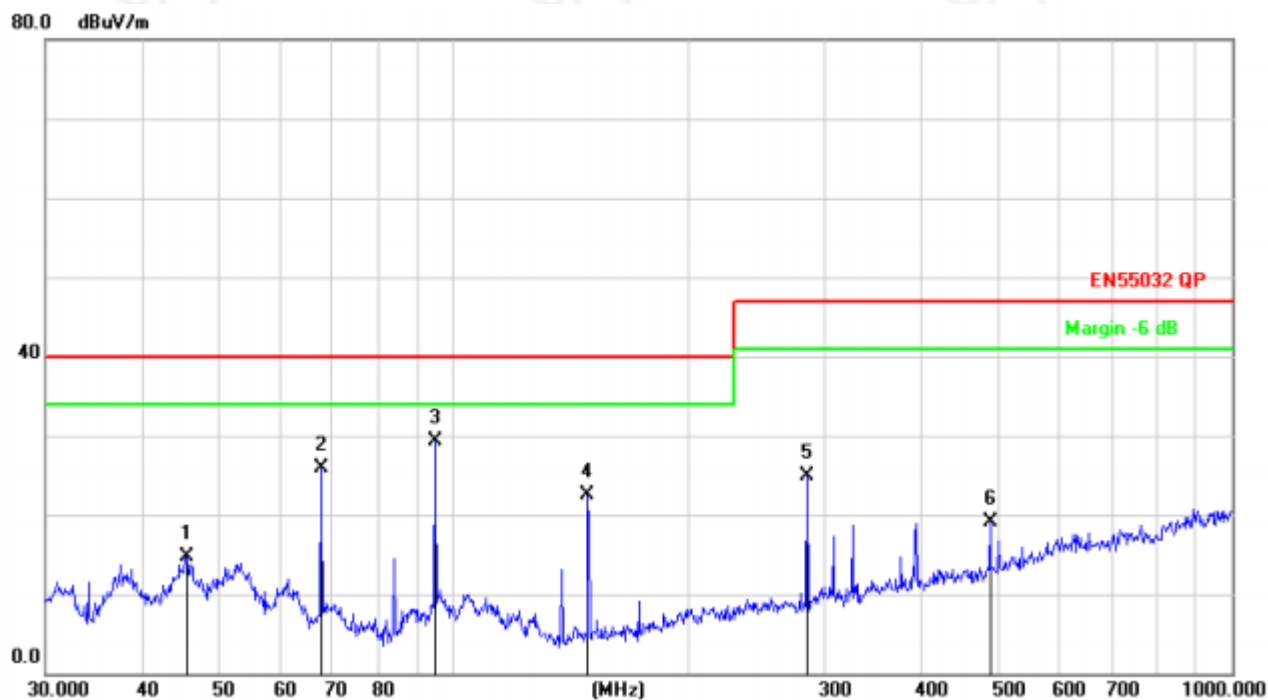
Radiated Emissions Test Data			
Temperature:	26°C	Relative Humidity:	54%
Pressure:	1009hPa	Phase :	Horizontal
Test Voltage :	AC 230V/50Hz	Test Mode:	Working



No.	Mk.	Freq.	Reading Level	Correct Factor	Measurement	Limit	Over	Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	cm	degree	Comment
1		67.6751	37.60	-17.13	20.47	40.00	-19.53	QP		
2		119.4361	38.65	-17.35	21.30	40.00	-18.70	QP		
3	*	189.7385	53.02	-17.11	35.91	40.00	-4.09	QP		
4		230.9068	53.32	-15.90	37.42	47.00	-9.58	QP		
5		298.2681	40.93	-13.55	27.38	47.00	-19.62	QP		
6		556.7744	37.52	-8.05	29.47	47.00	-17.53	QP		

**Radiated Emissions Test Data**

Temperature:	26℃	Relative Humidity:	54%
Pressure:	1009hPa	Phase :	Vertical
Test Voltage :	AC 230V/50Hz	Test Mode:	Working



No.	Mk.	Freq.	Reading Level	Correct Factor	Measurement	Limit	Over	Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	cm	degree	Comment
1		45.5348	28.73	-14.03	14.70	40.00	-25.30	QP		
2		67.6751	43.09	-17.13	25.96	40.00	-14.04	QP		
3	*	94.7601	45.88	-16.53	29.35	40.00	-10.65	QP		
4		148.9625	41.45	-19.02	22.43	40.00	-17.57	QP		
5		284.9767	39.14	-14.30	24.84	47.00	-22.16	QP		
6		489.0269	28.93	-9.85	19.08	47.00	-27.92	QP		



## 7. IMMUNITY TEST OF GENERAL THE PERFORMANCE CRITERIA

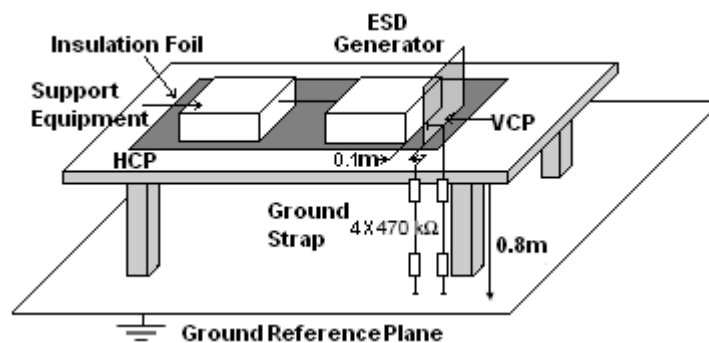
Product Standard	EN 55035:2017 clause 5
<b>CRITERION A</b>	<p>The equipment shall continue to operate as intended without operator intervention. No degradation of performance, loss of function or change of operating state is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.</p>
<b>CRITERION B</b>	<p>During the application of the disturbance, degradation of performance is allowed. However, no unintended change of actual operating state or stored data is allowed to persist after the test.</p> <p>After the test, the equipment shall continue to operate as intended without operator intervention; no degradation of performance or loss of function is allowed, below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.</p> <p>If the minimum performance level (or the permissible performance loss), or recovery time, is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.</p>
<b>CRITERION C</b>	<p>Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A reboot or re-start operation is allowed.</p> <p>Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.</p>

## 8. ELECTROSTATIC DISCHARGE (ESD)

### 8.1 Test Specification

<b>Test Port</b>	: Enclosure port
<b>Discharge Impedance</b>	: 330 ohm / 150 pF
<b>Discharge Mode</b>	: Single Discharge
<b>Discharge Period</b>	: one second between each discharge

### 8.2 Block Diagram of Test Setup



### 8.3 Test Procedure

- Electrostatic discharges were applied only to those points and surfaces of the Product that are accessible to users during normal operation.
- The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- The time interval between two successive single discharges was at least 1 second.
- The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the Product.
- Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- Air discharges were applied with the round discharge tip of the discharge electrode approaching the Product as fast as possible (without causing mechanical damage) to touch the Product. After each discharge, the ESD generator was removed from the Product and re-triggered for a new single discharge. The test was repeated until all discharges were complete.



g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the Product. The ESD generator was positioned vertically at a distance of 0.1 meters from the Product with the discharge electrode touching the HCP.

h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the Product were completely illuminated. The VCP (dimensions 0.5m x 0.5m) was placed vertically to and 0.1 meters from the Product.

#### 8.4 Test Results

Discharge Method	Discharge Position	Voltage ( $\pm$ kV)	Min. No. of Discharge per polarity (Each Point)	Required Level	Performance Criterion
Contact Discharge	Conductive Surfaces	4	10	B	A
	Indirect Discharge HCP	4	10	B	A
	Indirect Discharge VCP	4	10	B	A
Air Discharge	Slots, Apertures, and Insulating Surfaces	8	10	B	A
Note: N/A					



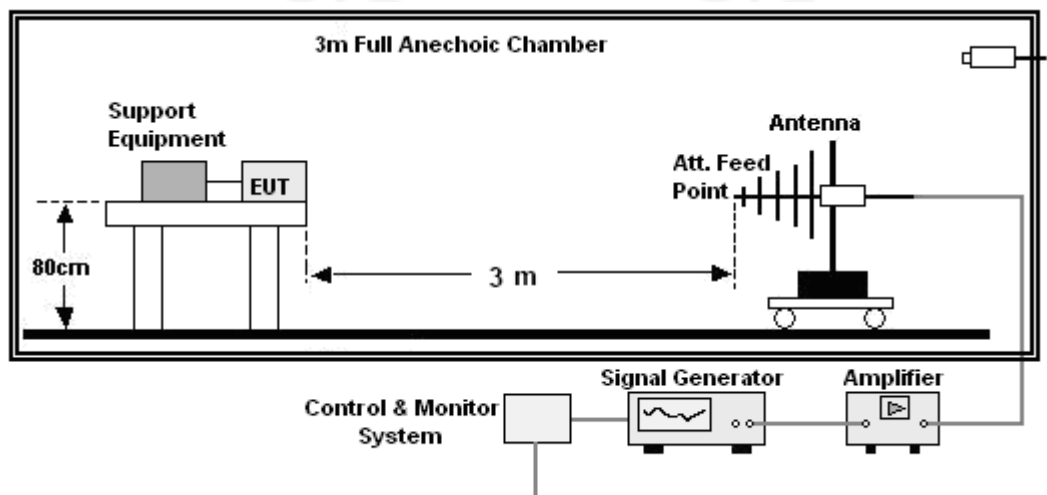
## 9. CONTINUOUS RF ELECTROMAGNETIC FIELD DISTURBANCES(RS)

### 9.1 Test Specification

<b>Test Port</b>	: Enclosure port
<b>Step Size</b>	: 1%
<b>Modulation</b>	: 1kHz, 80% AM
<b>Dwell Time</b>	: 1 second
<b>Polarization</b>	: Horizontal & Vertical

### 9.2 Block Diagram of Test Setup

Below 1GHz:



### 9.3 Test Procedure

- The testing was performed in a fully-anechoic chamber. The transmit antenna was located at a distance of 3 meters from the Product.
- The frequency range is swept from 80MHz to 1000MHz, 1800MHz, 2600MHz, 3500MHz, 5000MHz, with the signal 80% amplitude modulated with a 1 kHz sine wave, and the step size was 1%.
- The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised and to be able to respond, but should not exceed 5 s at each of the frequencies during the scan.
- The test was performed with the Product exposed to both vertically and horizontally polarized fields on each of the four sides.
- For Broadcast reception function: Group 2 not apply in this test.

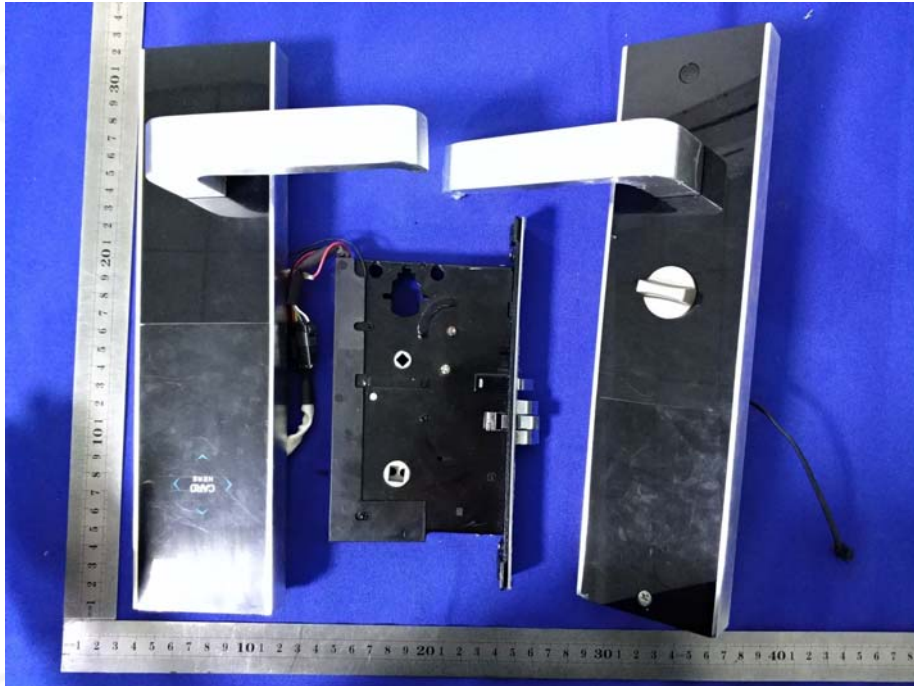


#### 9.4 Test Results

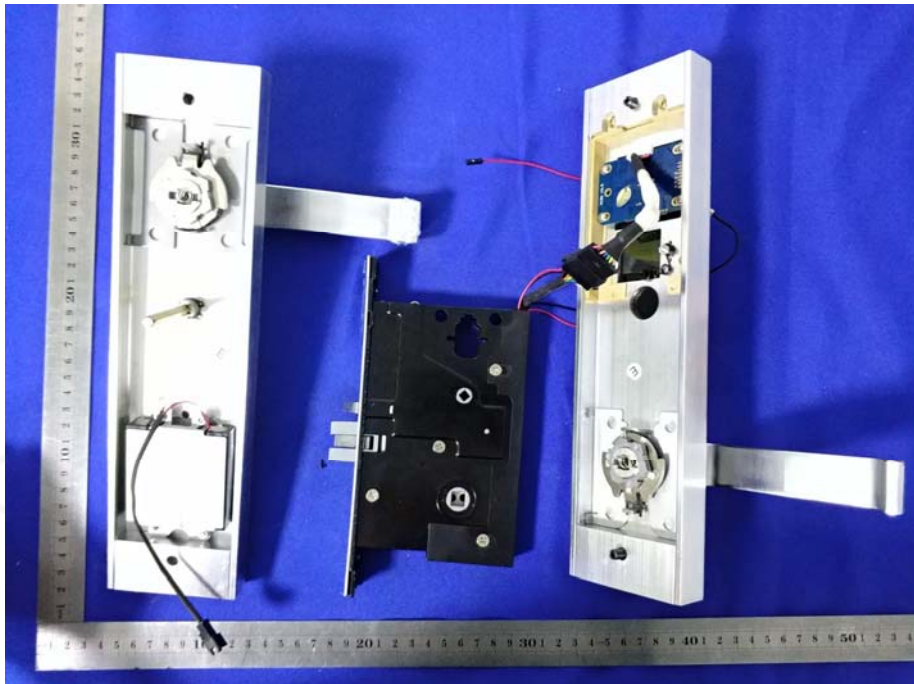
Frequency	Position	Field Strength (V/m)	Required Level	Performance Criterion
80 - 1000MHz, 1800MHz, 2600MHz, 3500MHz, 5000MHz	Front, Right, Back, Left	3	A	A
Note: N/A				

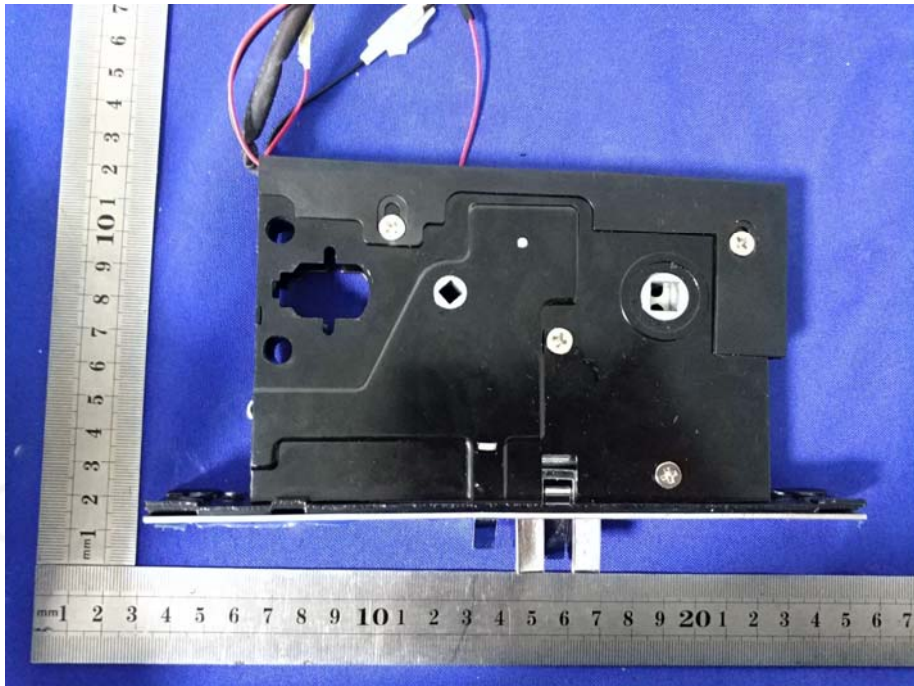
## 10. EUT PHOTOGRAPHS

EUT Photo 1



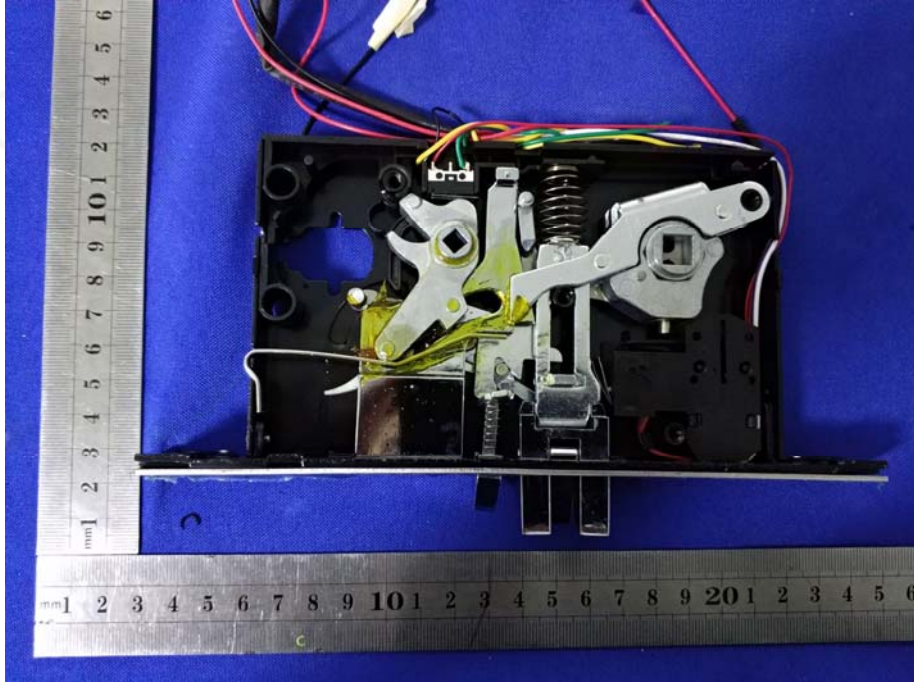
EUT Photo 2



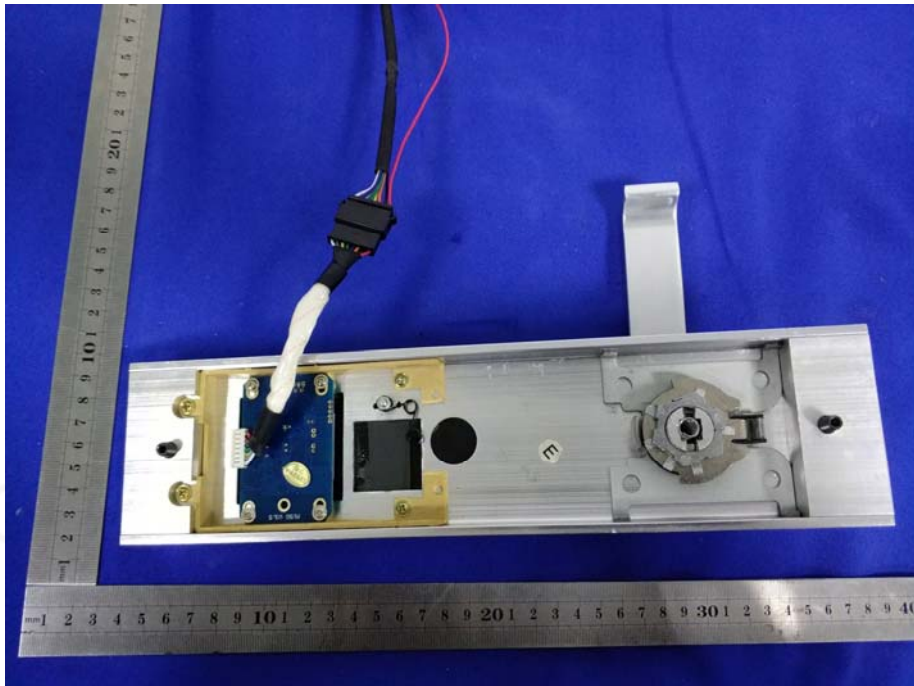
**EUT Photo 3****EUT Photo 4**



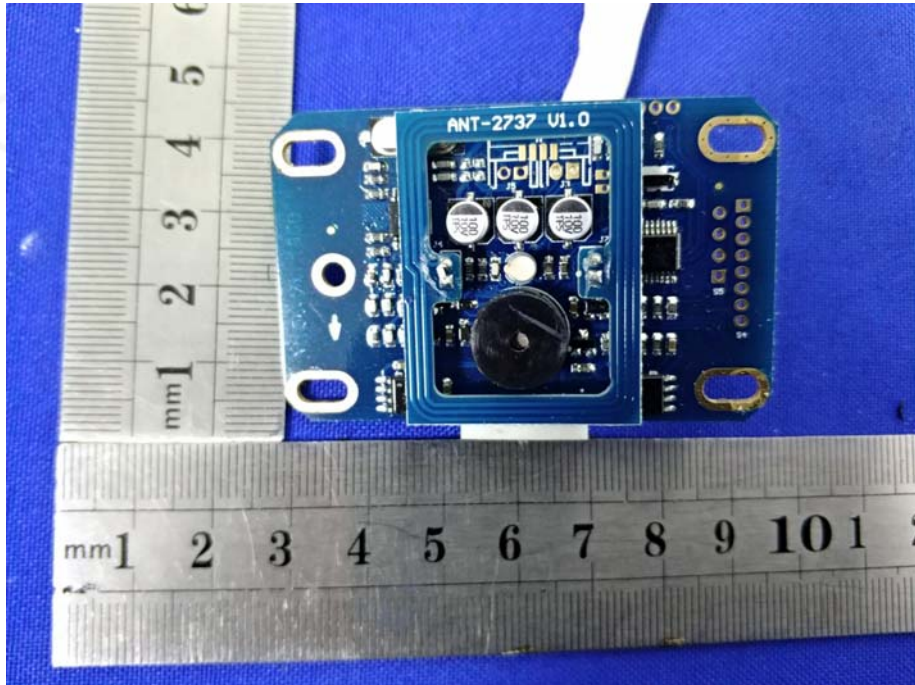
**EUT Photo 5**



**EUT Photo 6**



**EUT Photo 7**



## 11. EUT TEST SETUP PHOTOGRAPHS

Radiated emissions



ESD







RS



\*\*\*\*\* END OF REPORT \*\*\*\*\*